

N-Channel 25 V (D-S) MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A) ^{a, e}	Q _g (Typ.)	
25	0.0029 at V _{GS} = 10 V	65	17.5 nC	
25	0.0034 at V _{GS} = 4.5 V	58	17.5110	

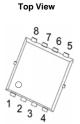
FEATURES

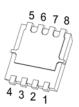
- DT-Trench Power MOSFET
- 100 % R_g and UIS Tested

APPLICATIONS

- · Notebook PC Core
- VRM/POL

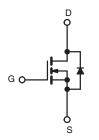
PDFN 3.3x3.3





Bottom View





N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS	S (T _A = 25 °C, unle	ess otherwise n	oted)	
Parameter	Symbol	Limit	Unit	
Drain-Source Voltage	V _{DS}	25	V	
Gate-Source Voltage		V _{GS}	± 12	
	T _C = 25 °C		65 ^{a, e}	
Continuous Drain Current (T _J = 175 °C)	T _C = 70 °C		58 ^e	
Continuous Diam Current (1) = 175 C)	T _A = 25 °C	l _D –	36 ^{b, c}	A
	T _A = 70 °C		29 ^{b, c}	
Pulsed Drain Current		I _{DM}	260	
Avalanche Current Pulse L = 0.1 mH		I _{AS}	20	
Single Pulse Avalanche Energy	L = 0.111111	E _{AS}	25	mJ
Continuous Source-Drain Diode Current	T _C = 25 °C	I _S	65 ^{a, e}	A
Continuous Source-Diam Diode Current	T _A = 25 °C	'S	5.1 ^{b, c}	7
	T _C = 25 °C		49	
Maximum Power Dissipation	T _C = 70 °C	P _D	35	W
Maximum Fower Dissipation	T _A = 25 °C	'D	4.6 ^{b, c}	
	T _A = 70 °C		3.9 ^{b, c}	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 175	°C

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, d}	t ≤ 10 s	R _{thJA}	25	35	°C/W	
Maximum Junction-to-Case	Steady State	R _{thJC}	2.5	4	G/ V V	

- Notes:
 a. Based on T_C = 25 °C.
 b. Surface mounted on 1" x 1" FR4 board.
 c. t = 10 s.
 d. Maximum under steady state conditions is 90 °C/W.
- e. Calculated based on maximum junction temperature. Package limitation current is 80 A.



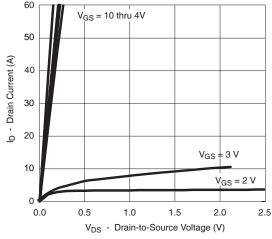
Parameter	Symbol	Test Conditions	Min .	Тур.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	25			V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = 250 μA		35		m\//°C
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	1 _D = 230 μΑ		- 5.5		mV/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	0.5		2.5	V
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA
Zoro Coto Voltogo Drain Current	I _{DSS}	V _{DS} = 20 V, V _{GS} = 0 V		1		
Zero Gate Voltage Drain Current		$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			10	μA
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$ 65				Α
D : 0	D.	V _{GS} = 10 V, I _D = 15 A		0.0029	0.0029 0.0038	
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 4.5 V, I _D = 10 A		0.0034	0.0040	Ω
Forward Transconductance ^a	g _{fs}	V _{DS} = 20 V, I _D = 15A		90		S
Dynamic ^b						
Input Capacitance	C _{iss}			2059		pF
Output Capacitance	C _{oss}	$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		698		
Reverse Transfer Capacitance	C _{rss}			161		
Total Gate Charge	Qg	$V_{DS} = 20 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 15 \text{ A}$		30		nC
				17.5		
Gate-Source Charge	Q _{gs}	$V_{DS} = 20 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 10 \text{ A}$		6		
Gate-Drain Charge	Q _{gd}			3.5		
Gate Resistance	R_g	f = 1 MHz		1.0	2.1	Ω
Turn-On Delay Time	t _{d(on)}			12	25	
Rise Time	t _r	V_{DD} = 20 V, R_L = 0.555 Ω		26	57	
Turn-Off Delay Time	t _{d(off)}	$I_D\cong$ 15 A, V_{GEN} = 10 V, R_g = 1 Ω		18	35	
Fall Time	t _f			10	25	
Turn-On Delay Time	t _{d(on)}			22	43	ns
Rise Time	t _r	V_{DD} = 20 V, R_L = 0.625 Ω		60	130	
Turn-Off Delay Time	t _{d(off)}	$I_D\cong$ 10 A, V_{GEN} = 4.5 V, R_g = 1 Ω		15	33	
Fall Time	t _f			12	28	
Drain-Source Body Diode Characteristic	s					
Continuous Source-Drain Diode Current	Is	T _C = 25 °C			65	٨
Pulse Diode Forward Current ^a	I _{SM}				260	Α
Body Diode Voltage	V _{SD}	I _S = 12 A		0.8	1.2	V
Body Diode Reverse Recovery Time	t _{rr}			29	58	ns
Body Diode Reverse Recovery Charge Q_{rr} Reverse Recovery Fall Time t_a		L = 10 A di/dt = 100 A/up T = 05 °C		16	32	nC
		$I_F = 10 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		12		ns
Reverse Recovery Rise Time	t _b	_		17		

Notes:

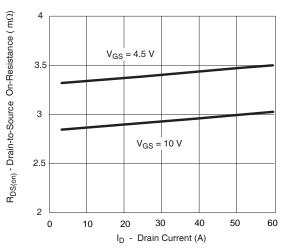
- a. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %.
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

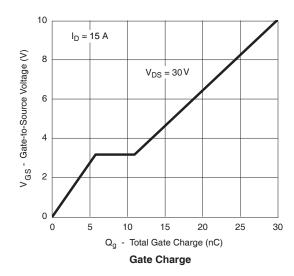
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

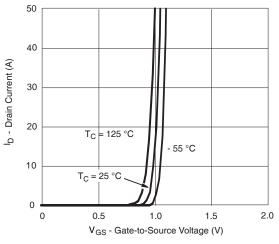


Output Characteristics

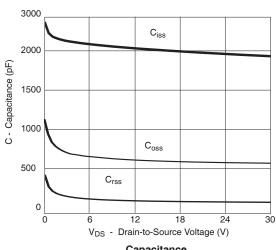


R_{DS(on)} vs. Drain Current

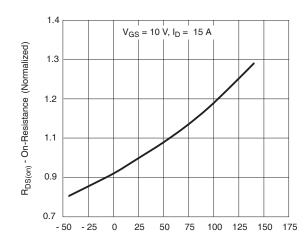




Transfer Characteristics



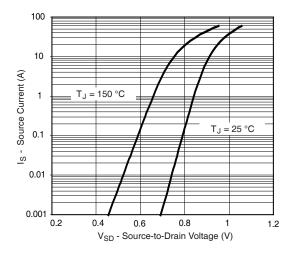
Capacitance



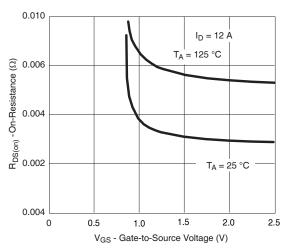
On-Resistance vs. Junction Temperature



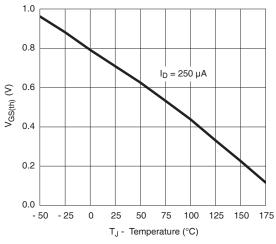
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



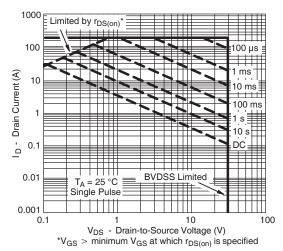
Forward Diode Voltage vs. Temperature



 $R_{DS(on)}$ vs. V_{GS} vs. Temperature

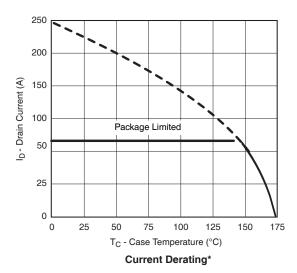


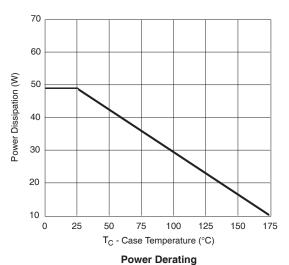
Threshold Voltage



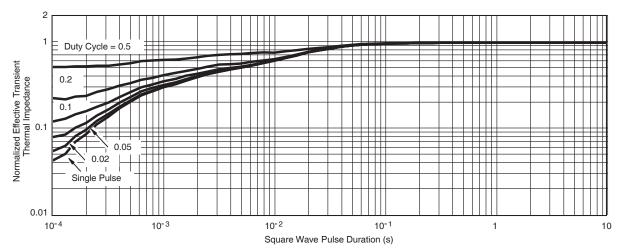
Safe Operating Area, Junction-to-Ambient

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



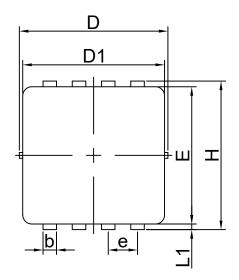


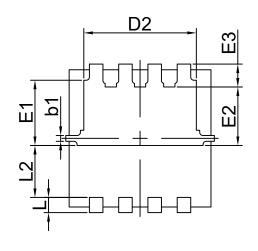
* The power dissipation P_D is based on $T_{J(max)} = 175$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

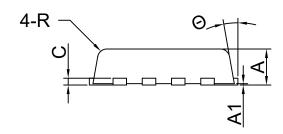


Normalized Thermal Transient Impedance, Junction-to-Case

PDFN3.3*3.3-8L Case Outline







SYMBOL	MIN NOM		MAX	
Α	0.70	0.80	0.90	
A_1	0.00	0.03	0.05	
b	0.24	0.30	0.35	
b1	0.08	0.13	0.18	
С	0	.152REI	F	
D	3.25	3.32	3.40	
D1	3.05	3.15	3.25	
D2	2.40	2.50	2.60	
Е	3.00	3.10	3.20	
E1	1.35	1.45	1.55	
E2	1.20	1.30	1.40	
E3	0.40	0.50	0.60	
е	0.65 BSC			
Н	3.20	3.30	3.40	
L	0.30	0.40	0.50	
L1	0.10	0.15	0.20	
L2	1.13 REF			
R	0.20 REF			
Θ	6°	10°	14°	





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